

Search Notes

Application/Control No.

09/867,967

Examiner

Nhon T. Diep

Applicant(s)/Patent under
Reexamination

SHEN ET AL.

Art Unit

2613

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Discussed with T. CHIN on 10/1 (claim 28)	10/20/05	N.D.